

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination
		10/645,566	JEON ET AL.
Examiner Nathan Danielsen		Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0156294	08-2004	Watanabe et al.	369/094
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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